

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10582594	BEIER ET AL.
Examiner	Art Unit	
Patrick F O'Reilly III	3749	

SEARCHED

Class	Subclass	Date	Examiner
454	71, 72, 76	7/28/2008	PFO3
62	172	7/28/2008	PFO3

SEARCH NOTES

Search Notes	Date	Examiner
EAST (USPAT, US-PGPUB, USOCR, EPO, JPO DERWENT, IBM_TDB) searched - printout attached.	7/27/2008; 7/28/2008	PFO3
PLUS search performed - refer to search results in eDAN.	7/25/2008	STIC
Inventor name search performed in PALM and EAST.	7/28/2008	PFO3

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner